

# GSM2336A

## 30V N-Channel Enhancement Mode MOSFET

### Product Description

GSM2336A, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer and other battery powered circuits, and low in-line power loss are needed in commercial industrial surface mount applications.

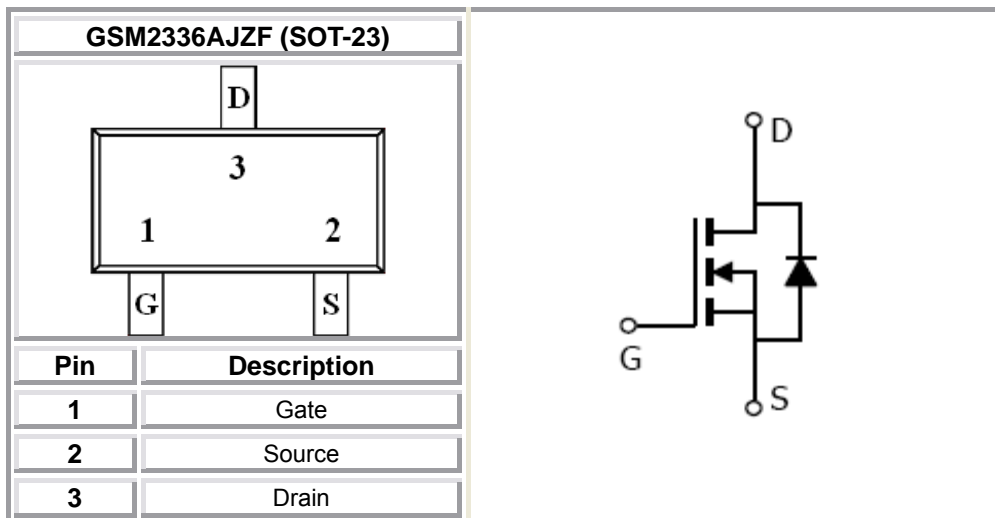
### Features

- 30V/1.8A,  $R_{DS(ON)}=380m\Omega@V_{GS}=4.5V$
- 30V/1.5A,  $R_{DS(ON)}=480m\Omega@V_{GS}=2.5V$
- 30V/1.2A,  $R_{DS(ON)}=900m\Omega@V_{GS}=1.8V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOT-23 package design

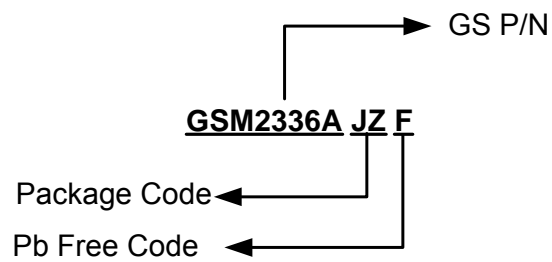
### Applications

- Direct Logic-Level Interface: TTL/CMOS
- Drivers: Relays, Solenoids, Lamps, Hammers
- Battery Operated Systems, DC/DC Converters
- Solid-State Relays
- Load/Power Switching-Cell Phones, Pagers

### Packages & Pin Assignments

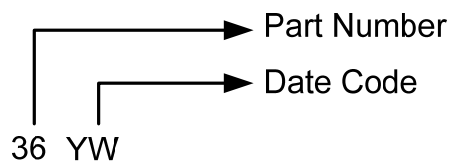


## Ordering Information



Part Number	Package	Quantity Reel
GSM2336AJZF	SOT-23	3000 PCS

## Marking Information



## Absolute Maximum Ratings

( $T_A=25^{\circ}\text{C}$  unless otherwise noted)

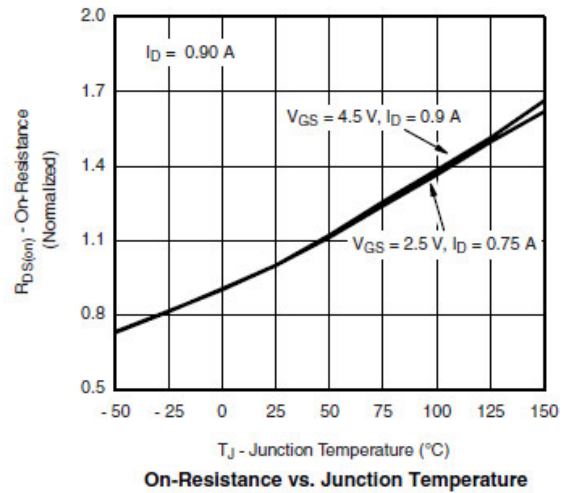
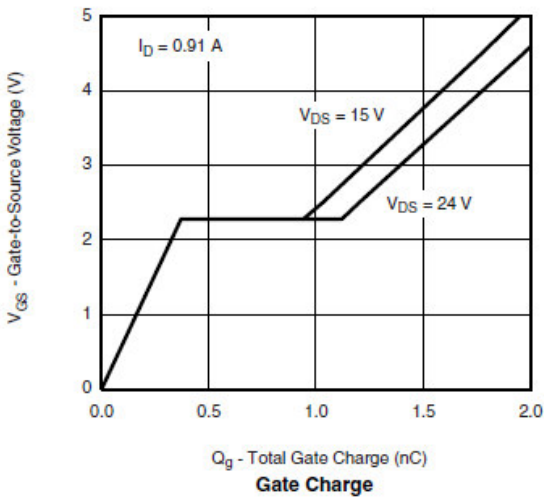
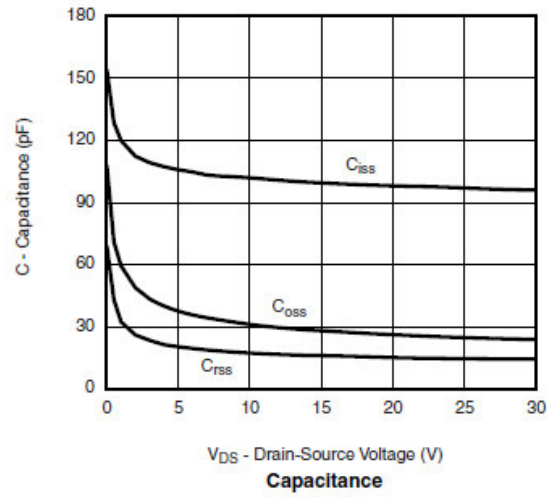
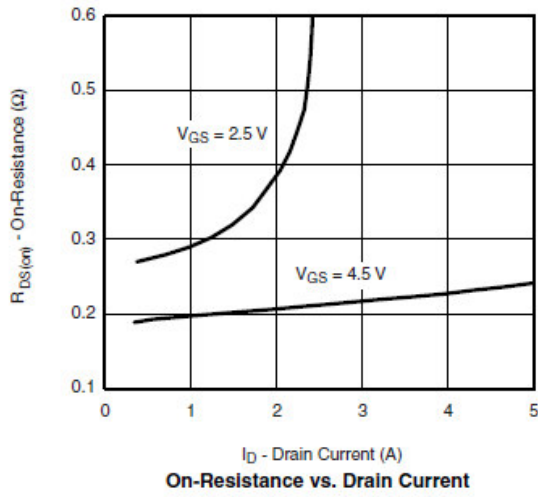
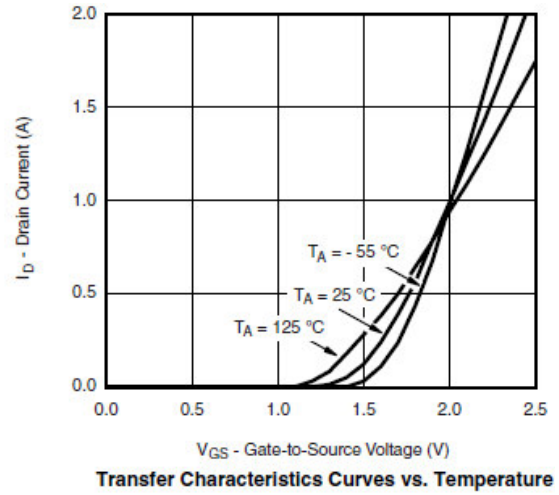
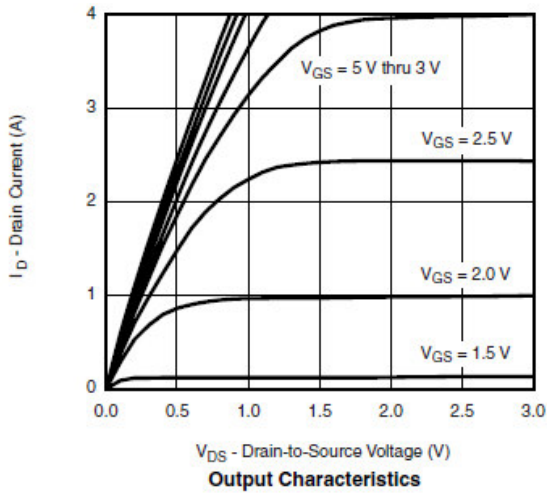
Symbol	Parameter	Typical	Unit
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate -Source Voltage	$\pm 12$	V
$I_D$	Continuous Drain Current( $T_J=150^{\circ}\text{C}$ )	$T_A=25^{\circ}\text{C}$	1.8
		$T_A=70^{\circ}\text{C}$	1.2
$I_{DM}$	Pulsed Drain Current	6	A
$I_S$	Continuous Source Current(Diode Conduction)	1	A
$P_D$	Power Dissipation	$T_A=25^{\circ}\text{C}$	1.25
		$T_A=70^{\circ}\text{C}$	0.8
$T_J$	Operating Junction Temperature	150	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-55/150	$^{\circ}\text{C}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	120	$^{\circ}\text{C}/\text{W}$

## Electrical Characteristics

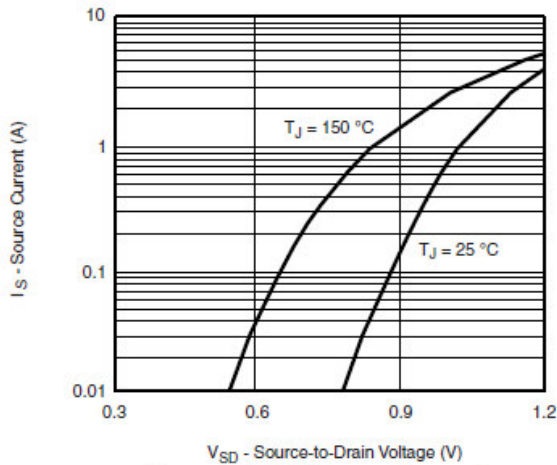
(T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.5		1.0	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V			1	μA
		V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =85°C			5	
I <sub>D(on)</sub>	On-State Drain Current	V <sub>DS</sub> ≥5V, V <sub>GS</sub> =4.5V	1.8			A
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =1.8A		350	380	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =1.5A		450	480	
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =0.5A		850	900	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =1.0A		1		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1.0A, V <sub>GS</sub> =0V		0.65	1.2	V
<b>Dynamic</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz		85		pF
C <sub>oss</sub>	Output Capacitance			25		
C <sub>rss</sub>	Reverse Transfer Capacitance			15		
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =1.2A		1.4	1.8	nC
Q <sub>gs</sub>	Gate-Source Charge			0.3		
Q <sub>gd</sub>	Gate-Drain Charge			0.6		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =15V, R <sub>L</sub> =20Ω, I <sub>D</sub> =1.2A, V <sub>GEN</sub> =4.5V, R <sub>G</sub> =1Ω		15	25	ns
t <sub>r</sub>				25	45	
t <sub>d(off)</sub>	Turn-Off Time			15	25	
t <sub>f</sub>				10	20	

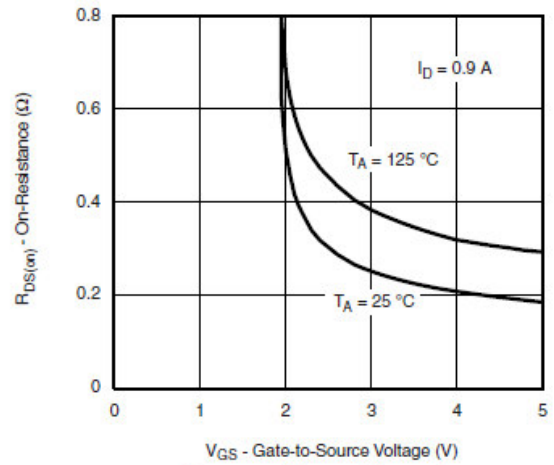
## Typical Performance Characteristics



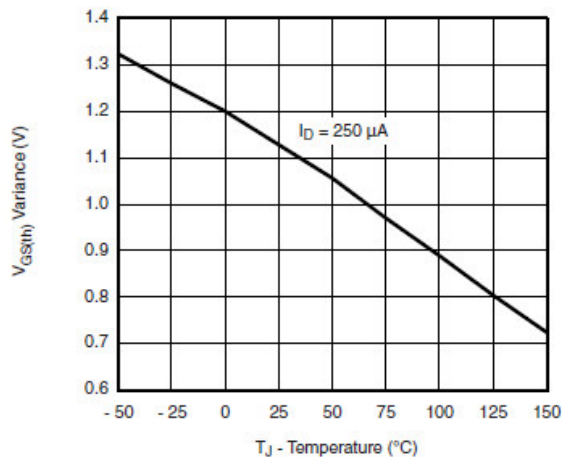
## Typical Performance Characteristics (continue)



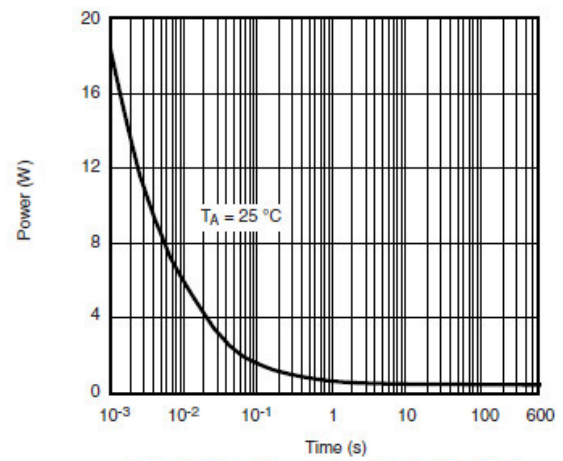
Forward Diode Voltage vs. Temperature



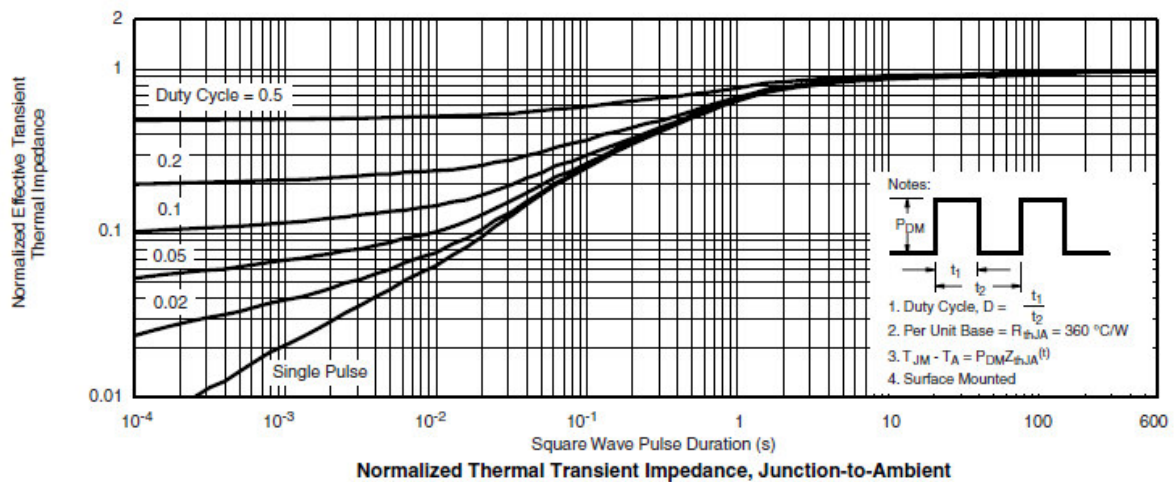
$R_{DS(on)}$  vs.  $V_{GS}$  vs. Temperature



Threshold Voltage



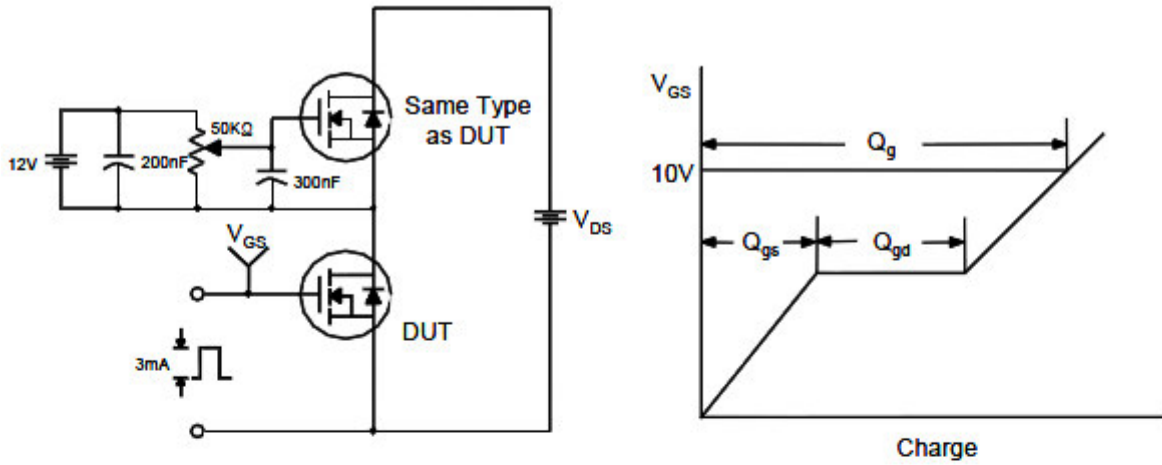
Single Pulse Power, Junction-to-Ambient



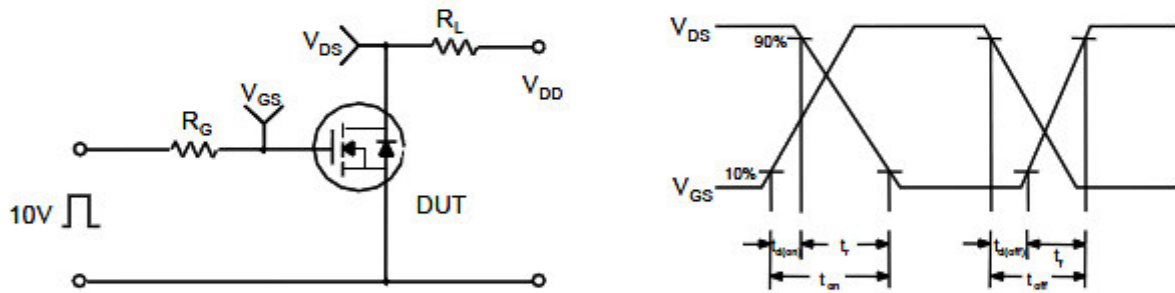
Normalized Thermal Transient Impedance, Junction-to-Ambient

## Typical Performance Characteristics (continue)

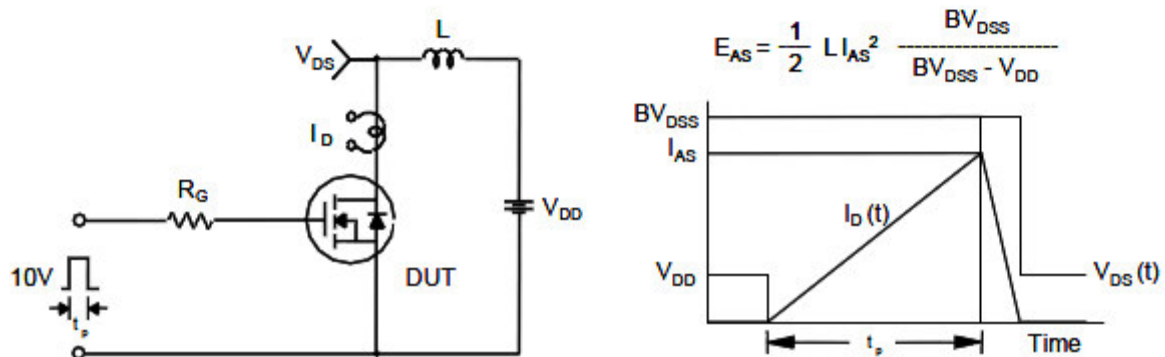
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms

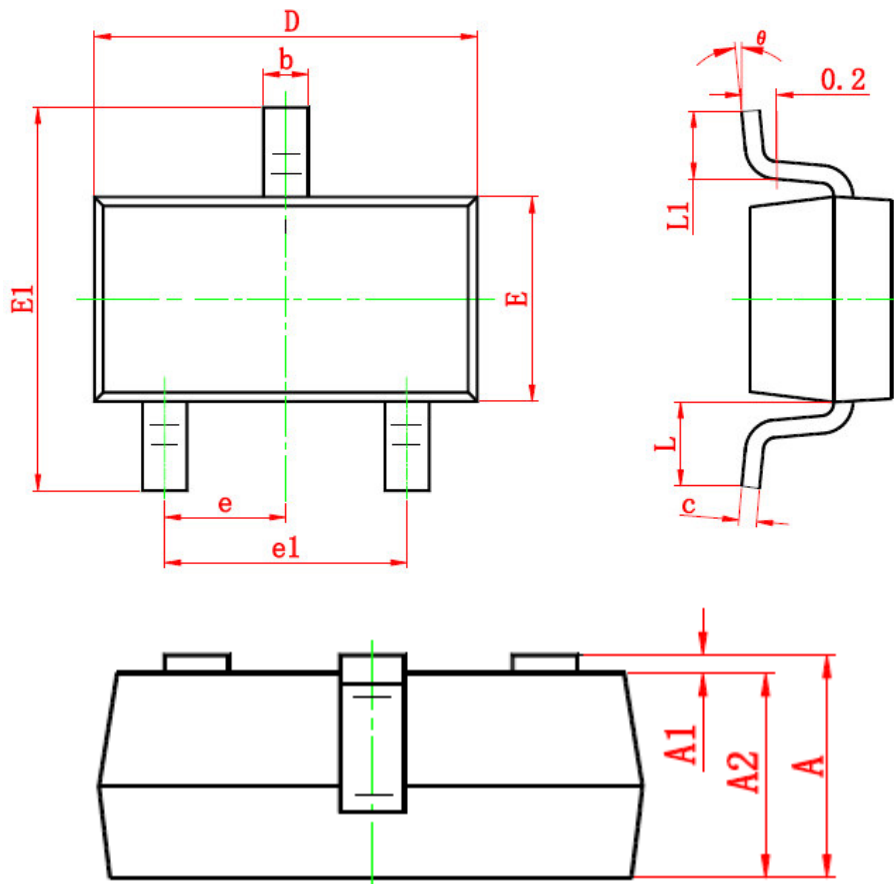


### Unclamped Inductive Switching Test Circuit & Waveforms



## Package Dimension

### SOT-23 PLASTIC PACKAGE







Dimensions				
SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.90	1.20	0.035	0.043
A1	0.00	0.10	0.000	0.004
A2	0.90	1.10	0.035	0.039
b	0.30	0.50	0.012	0.020
c	0.08	0.15	0.003	0.006
D	2.80	3.00	0.110	0.118
E	1.20	1.40	0.047	0.055
E1	2.25	2.55	0.089	0.100
e	0.950 (TYP)		0.037 (TYP)	
e1	1.80	2.00	0.071	0.079
L	0.550 (REF)		0.022 (REF)	
L1	0.30	0.50	0.012	0.020
Q	0°	8°	0°	8°



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